

# SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS

# PRODUCT SPECIFICATION

# 規格書

**CUSTOMER:** DATE:

(客戶): 志盛翔 (日期): 2020-1-17

CATEGORY (品名) : ALUMINUM ELECTROLYTIC CAPACITORS

DESCRIPTION (型号) : RT  $450V82\mu F(\phi 18X25)$ 

VERSION (版本) : 01

Customer P/N :

SUPPLIER :

SUPPLIER									
PREPARED (拟定)	CHECKED (审核)								
赵安平	刘渭清								

CUSTOMER									
APPROVAL	SIGNATURE								
(批准)	(签名)								

# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

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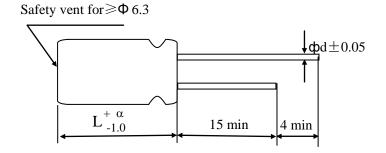
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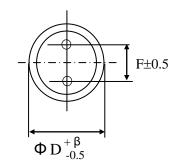
## ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

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Table 1 Product Dimensions and Characteristics

Unit: mm





α	L<20 : α=1.5; L≥20 : α=2.0
β	$\Phi D < 20 : \beta = 0.5; \ \Phi D \ge 20 : \beta = 1.0$

\* If it is flat rubber, there is no bulge from the flat rubber surface.

No.	SAMXON Part No.	WV (Vdc)	Cap. (μF)	Cap tolerance	Temp. range( $^{\circ}\mathbb{C}$ )	tan <b>δ</b> (120Hz, 20℃)	Leakage Current (μ <b>A,2min</b> )	Max Ripple Current at 105℃ 100kHz (mArms)	Load lifetime (Hrs)		ension (mm) F	фd	Sleeve
1	ERT826M2WL25RR**Z	450	82	-20%~+20%	-25~105	0.20	763	1633	5000	18X25	7.5	0.8	PET

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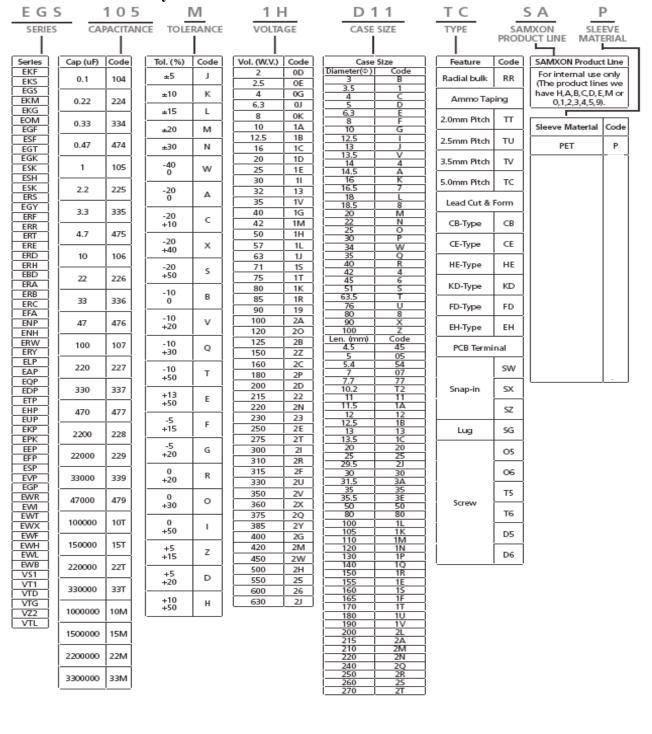
## ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

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### 1. Application

This specification applies to polar Aluminum electrolytic capacitor (foil type) used in electronic equipment. Designed capacitor's quality meets IEC60384.

### 2. Part Number System



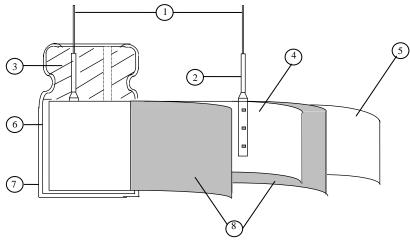
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## ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

# **SAMXON**

#### 3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



No	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	PET
8	Separator	Electrolyte paper

#### 4. Characteristics

#### Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature :15°C to 35°C
Relative humidity : 45% to 85%
Air Pressure : 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature  $: 20^{\circ}\text{C} \pm 2^{\circ}\text{C}$ Relative humidity : 60% to 70%Air Pressure : 86kPa to 106kPa

### Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

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# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

Tabl	e 2											
	ITEM				PE	RFORN	IANCE	,				
	Rated voltage (WV)											
4.1		WV (V.DC)	160	200	220	250	350	400	420	450		
	Surge voltage (SV)	SV (V.DC)	200	250	270	300	400	450	470	500		
4.2	Nominal capacitance (Tolerance)	<condition> Measuring F Measuring V Measuring T <criteria> Shall be with</criteria></condition>	requen oltage emper	ature	: Not m : 20±2	${\mathbb C}$	ı 0.5Vrı					
4.3	Leakage current	<condition> Connecting t minutes, and <criteria> Refer to Tabl</criteria></condition>	he cap then, n		-			tor (1	kΩ ±1	0Ω) in	n series for	
4.4	tanδ	<condition> See 4.2, Norr <criteria> Refer to Tabl</criteria></condition>	m Capa	acitance	, for me	asuring	; freque	ncy, vo	ltage ar	nd temp	erature.	
4.5	Terminal strength	0.5r Over 0.	rength capacitor apacitor apac	or, applof of Term r, applications, a cand wire dead wire dead wire o 0.8mm	inals. ed force and then	to bent it bent it reside (kg 5 (0 10 (	the terr for 90° force N gf) 0.51)	ninal (1	~4 mm original Bendin (1 2.5 5 (	g force kgf) (0.25)	he rubber) on within 2	for 2~3

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# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

			<condition></condition>						
2			STEP	Testing Temp	$\operatorname{berature}({}^{\circ}\mathbb{C})$		Time		
3   20±2   Time to reach thermal equing the product of the production of the product of the p			1	20±	2	Time to re	each thermal	equilibriu	ım
4   105±2   Time to reach thermal equing to reach thermal equing the specified value of the specified value. Solution that the specified value of the specifi			2	-40(-25	) ±3	Time to re	each thermal	equilibriu	ım
Temperature characteristics  4.6  Temperature characteristics  4.7  Temperature characteristics  4.6  Temperature characteristics  4.7  Temperature characteristics shall be within the limit of Item 4.4The leakage current measure more than 8 times of its specified value.  4.7  Temperature characteristics  4.6  Temperature characteristic shall be within the limit of Item 4.4The leakage current beautiful to the within the limit of Item 4.4The leakage current leakage current leakage current leakage current leakage current leakage of leakage current leakage cu			3	20±	2	Time to re	each thermal	equilibriu	ım
Temperature characteristics  4.6  Temperature characteristics  5			4	105 =	<u>±2</u>	Time to re	each thermal	equilibriu	ım
Criteria> a. tanδ shall be within the limit of Item 4.4The leakage current measure more than 8 times of its specified value. b. In step 5, tanδ shall be within the limit of Item 4.4The leakage current measure more than 8 times of its specified value. c. At-40°C (-25°C), impedance (z) ratio shall not exceed the value of the table.    Working Voltage (V)   160   200   250   350   40     Z-25°C/Z+20°C   3   3   3   5   50     For capacitance value > 1000µ F, Add 0.5 per another 1000µ F for Z-20     Add 1.0 per another 1000µ F for Z-40     Capacitance, tanδ , and impedance shall be measured at 120Hz.    Capacitance, tanδ   and impedance shall be measured at 120Hz.    Capacitance tand   and impedance shall be read or result should meet the following table:   Criteria>     Load   life test   Leakage current   Value in 4.3 shall be satisfied     Capacitance Change   Within ±20% of initial value.     Lamδ   Not more than 200% of the specified value.     Appearance   There shall be no leakage of electrolyte     Condition>     The capacitors are then stored with no voltage applied at a temperature of 1000+48/0 hours. Following this period the capacitors shall be removed chamber and be allowed to stabilized at room temperature for 4~8 hot shall be connected to a series limiting resistor(1k±100Ω) with D.C. applied for 30min. After which the capacitors shall be discharged, and the stabilized at stabilized at stand be discharged, and the standard be allowed to stabilized at room temperature for 4~8 hot shall be connected to a series limiting resistor(1k±100Ω) with D.C. applied for 30min. After which the capacitors shall be discharged, and the standard process of table			5	20±	2				
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characteristics cs    Cat-40°C (-25°C), impedance (z) ratio shall not exceed the value of the table.    Working Voltage (V)   160   200   250   350   40     Z-25°C/Z+20°C   3   3   3   5     For capacitance value > 1000μ F, Add 0.5 per another 1000μ F for Z-2:   Add 1.0 per another 1000μ F for Z-2:   Add 1.0 per another 1000μ F for Z-40     Capacitance, tanδ , and impedance shall be measured at 120Hz.    Capacitance, tanδ   and impedance shall be measured at 120Hz.    Capacitance the following table:   Capacitance the following requirements.     Load life test   Capacitance Change   Within ±20% of initial value.     Lanδ   Not more than 200% of the specified value and table the following table:     Capacitance Change   There shall be no leakage of electrolyte     Condition>   The capacitors are then stored with no voltage applied at a temperature of 1000+48/0 hours. Following this period the capacitors shall be removed chamber and be allowed to stabilized at room temperature for 4-8 hot shall be connected to a series limiting resistor(1k±100Ω) with D.C. applied for 30min. After which the capacitors shall be discharged, and the shall be discharged, and the stable capacitors shall be capacitors shall be discharged, and the stable capacitors shall be discharged.		_	more than 8 tir	nes of its specif	fied value.				
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Condition		CS		.5℃), impedanc	ce (z) ratio sh	all not exce	ed the value	of the fol	lowing
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The characteristic shall meet the following requirements.  Leakage current Value in 4.3 shall be satisfied Capacitance Change Within ±20% of initial value.  tanδ Not more than 200% of the specified value appearance There shall be no leakage of electrolyte   Condition> The capacitors are then stored with no voltage applied at a temperature of 1000+48/0 hours. Following this period the capacitors shall be removed chamber and be allowed to stabilized at room temperature for 4~8 hou shall be connected to a series limiting resistor(1k±100Ω) with D.C.  applied for 30min. After which the capacitors shall be discharged, and the stabilized at room temperature for 4~8 hou shall be connected to a series limiting resistor(1k±100Ω) with D.C.		Load		neet the followir	ng table:				
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The capacitors are then stored with no voltage applied at a temperature of 1000+48/0 hours. Following this period the capacitors shall be removed chamber and be allowed to stabilized at room temperature for 4~8 hou shall be connected to a series limiting resistor(1k±100Ω) with D.C. applied for 30min. After which the capacitors shall be discharged, and the stabilized at 100Ω is with D.C. applied for 30min.			-Conditions						
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chamber and be allowed to stabilized at room temperature for $4{\sim}8$ hou shall be connected to a series limiting resistor( $1k\pm100\Omega$ ) with D.C. applied for 30min. After which the capacitors shall be discharged, and the									
Shelf shall be connected to a series limiting resistor( $1k\pm100\Omega$ ) with D.C. applied for 30min. After which the capacitors shall be discharged, and the				_					
4.8 life applied for 30min. After which the capacitors shall be discharged, and the		Shelf				_			
	1.8				_				_
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		l e							

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		<criteria></criteria>	
			Walue in 4.3 shall be satisfied
	Shelf	Leakage current	
4.8	life	Capacitance Change	Within $\pm 20\%$ of initial value.
	test	tanδ	Not more than 200% of the specified value.
		Appearance	There shall be no leakage of electrolyte.
		•	e stored more than 1 year, the leakage current may
		<ul><li>Increase. Please apply voltage</li><li>Condition&gt;</li></ul>	e through about 1 kΩresistor, if necessary.
	G.	Applied a surge voltage to the	pe 15~35°C.
4.9	Surge	Leakage current	Not more than the specified value.
	test	Capacitance Change	Within $\pm 15\%$ of initial value.
		tanδ	Not more than the specified value.
		Appearance	There shall be no leakage of electrolyte.
		Attention:	
		This test simulates over voltage as often applied	age at abnormal situation only. It is not applicable to sucl
4.10	Vibration test	The following conditions sh perpendicular directions.  Vibration frequency rate  Peak to peak amplitud  Sweep rate  Mounting method:	e : 1.5mm : 10Hz ~ 55Hz ~ 10Hz in about 1 minute greater than 12.5mm or longer than 25mm must be fixed Within 30°
		<criteria> After the test, the follow</criteria>	To be soldered ing items shall be tested: No intermittent contacts, open or short
		Inner construction	circuiting. No damage of tab terminals or electrodes.  No mechanical damage in terminal. No leakage
		Appearance	of electrolyte or swelling of the case.

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		<condition></condition>	. 1 1 1 611	11.1		
		The capacitor shall be tes	•	conditions:		
4.11		Soldering temperature	: 245±3°C			
	Solderability	Dipping depth	: 2mm : 25±2.5mm	la.		
	test	Dipping speed	: 25±2.5mm : 3±0.5s	/S		
	test	Dipping time < Criteria >	: 3±0.38			
			A minimur	n of 95% of the surface being	1	
		Coating quality	immersed	in or 55% or the surface being		
					ı	
		<condition></condition>				
		Terminals of the capac	citor shall be immersed i	nto solder bath at		
		$260\pm5$ °C for $10\pm1$ sec	onds or $400 \pm 10^{\circ}$ C for 3	$_{-0}^{+1}$ seconds to 1.5~2.0mm from	m the	
		body of capacitor.				
	Resistance to	Then the capacitor sha	all be left under the norm	nal temperature and normal		
4.12	solder heat		s before measurement.			
	test	<criteria></criteria>				
		Leakage current	Not more than the			
		Capacitance Change	Within ±10% of			
		tanδ	Not more than the	•		
		Appearance	There shall be no i	eakage of electrolyte.		
		<condition></condition>				
	Change of	Temperature Cycle:Accor	rding to IEC60384-4No.	4.7methods, capacitor shall be	e	
		placed in an oven, the cor				
		Te	Time			
		(1)+20°C		≤3 Minutes		
		(2)Rated low temper	ature (-40°C) (-25°C)	$30\pm2$ Minutes		
4.13	temperature	(3)Rated high temperature (+105°C) $30\pm2$ Minutes				
	test	(1) to (3)=1 cycle, to	tal 5 cycle			
		<criteria></criteria>				
		The characteristic shall m				
		Leakage current	Not more than the s	pecified value.		
		tanδ	Not more than the s	•		
		Appearance	There shall be no le	akage of electrolyte.		
		<condition></condition>				
		Humidity Test:				
			4-4No.4.12methods, cap			
		_	hours in an atmosphere			
		$40\pm2^{\circ}\mathrm{C}$ , the characteri	stic change shall meet th	ne following requirement.		
		.C. '4. '				
4.14	Damp heat	<criteria></criteria>	X			
	test	Leakage current	Not more than the spec			
		Capacitance Change	Within $\pm 20\%$ of initial			
		tanδ	Not more than 120% of	•		
		Appearance	There shall be no leak	age of electrolyte.		

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4.15	Vent test	Condition> The following test only apply to those products with vent products at diameter ≥∅6.3 with vent. D.C. test The capacitor is connected with its polarity reversed to a DC power source. Then a current selected from below table is applied.  Table 3> Diameter (mm) DC Current (A) 22.4 or less 1 Over 22.4 10 Criteria> The vent shall operate with no dangerous conditions such as flames or dispersion of pieces of the capacitor and/or case.
4.16	Maximum permissible (ripple current)	Condition> The maximum permissible ripple current is the maximum A.C current at 120Hz and can be applied at maximum operating temperature Table-1 The combined value of D.C voltage and the peak A.C voltage shall not exceed the rated voltage and shall not reverse voltage.  Frequency Multipliers:  Coefficient  (Hz)  120  1k  10k  100k  6.8~180  1.00  1.87  2.25  2.50
4.17	"S" countermea- sures	Condition> Test voltage : Rated voltage ×1.5 Current limit : 1A Max  Test circuit Criteria> After the capacitors are subjected to 1.5 times of the rated voltage for 10 minutes, at least 60% of the capacitors (sampling number=10pieces) shall be no venting or no short circuit even after venting and blowing up electrolyte. In addition, accumulative test result shall be at least 80%.

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5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances					
	Cadmium and cadmium compounds					
Heavy metals	Lead and lead compounds					
Ticavy metais	Mercury and mercury compounds					
	Hexavalent chromium compounds					
	Polychlorinated biphenyls (PCB)					
Chloinated	Polychlorinated naphthalenes (PCN)					
organic	Polychlorinated terphenyls (PCT)					
compounds	Short-chain chlorinated paraffins(SCCP)					
	Other chlorinated organic compounds					
D ' . 1	Polybrominated biphenyls (PBB)					
Brominated	Polybrominated diphenylethers(PBDE) (including					
organic	decabromodiphenyl ether[DecaBDE])					
compounds	Other brominated organic compounds					
Tributyltin compo	ounds(TBT)					
Triphenyltin com	pounds(TPT)					
Asbestos						
Specific azo com	pounds					
Formaldehyde						
Beryllium oxide						
Beryllium coppe	er					
Specific phthalate	es (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)					
Hydrofluorocarbo	on (HFC), Perfluorocarbon (PFC)					
Perfluorooctane s	pulfonates (PFOS)					
Specific Benzotri	azole					

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#### **Attachment: Application Guidelines**

#### 1.Circuit Design

1.1 Operating Temperature and Frequency

Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.

- (1) Effects of operating temperature on electrical parameters
  - a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
  - b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
- (2) Effects of frequency on electrical parameters
  - a) At higher frequencies capacitance and impedance decrease while tanδ increases.
  - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).

#### 1.2 Operating Temperature and Life Expectancy

See the file: Life calculation of aluminum electrolytic capacitor

#### 1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

#### (1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

#### (2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

#### (3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

#### (4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

#### 1.4 Using Two or More Capacitors in Series or Parallel

#### (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

#### (2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

### 1.5 Capacitor Mounting Considerations

#### (1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

#### (2)Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

#### (3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

#### (4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

 $\phi$ 6.3~ $\phi$ 16mm:2mm minimum,  $\phi$ 18~ $\phi$ 35mm:3mm minimum,  $\phi$ 40mm or greater:5mm minimum.

#### (5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

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#### (6) Wiring Near the Pressure Relief Vent

Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite.

(7) Circuit Board patterns Under the Capacitor

Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short.

(8) Screw Terminal Capacitor Mounting

Do not orient the capacitor with the screw terminal side of the capacitor facing downwards.

Tighten the terminal and mounting bracket screws within the torque range specified in the specification.

#### 1.6 Electrical Isolation of the Capacitor

Completely isolate the capacitor as follows.

- (1) Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths
- (2) Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths.
- 1.7 The Product endurance should take the sample as the standard.
- 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling.

#### 1.9 Capacitor Sleeve

The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor.

The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures.

#### CAUTION!

Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use.

- (1) Provide protection circuits and protection devices to allow safe failure modes.
- (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure.

#### 2. Capacitor Handling Techniques

- 2.1 Considerations Before Using
- (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment.
- (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about  $1k\Omega$ .
- (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately  $1k\Omega$ .
- (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors.
- (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result.

#### 2.2 Capacitor Insertion

- (1) Verify the correct capacitance and rated voltage of the capacitor.
- (2) Verify the correct polarity of the capacitor before inserting.
- (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals.
- (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor.

For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection.

#### 2.3 Manual Soldering

- (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less.
- (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal.
- (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads.
- (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve.

#### 2.4 Flow Soldering

- (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result.
- (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.
- (3) Do not allow other parts or components to touch the capacitor during soldering.

#### 2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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#### 2.6 Capacitor Handling after Solder

- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.

#### 2.7 Circuit Board Cleaning

- (1) Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

Alkali solvents : could attack and dissolve the aluminum case.

Petroleum based solvents: deterioration of the rubber seal could result.

Xylene : deterioration of the rubber seal could result.

Acetone : removal of the ink markings on the vinyl sleeve could result.

(3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the

circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.

(4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.

#### 2.8 Mounting Adhesives and Coating Agents

When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

#### 3. Precautions for using capacitors

3.1 Environmental Conditions

Capacitors should not be stored or used in the following environments.

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

#### 3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

#### 4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures.

If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.

If electrolyte or gas is ingested by month, gargle with water.

If electrolyte contacts the skin, wash with soap and water.

#### 5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause

the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a  $1000\Omega$ , current limiting resistor for a time period of 30 minutes . If the expired date of products date code is over eighteen months, the products should be return to confirmation.

#### 5.1 Environmental Conditions

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The capacitor shall be not use in the following condition:

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

#### 6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.

